





EH27 45

Series

RoHS Compliant (Pb-free) 2.5V 4 Pad 5mm x 7mm

Ceramic SMD LVCMOS Oscillator

Frequency Tolerance/Stability \_\_\_\_\_\_ ±50ppm Maximum

Operating Temperature Range – 0°C to +70°C

T TS -18.432M

Nominal Frequency 18.432MHz

Pin 1 Connection
Tri-State (High Impedance)

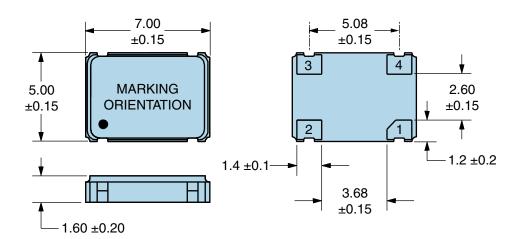
Duty Cycle 50 ±5(%)

Operating 260°C Ref  ing at 25°C	aximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°, ow, Shock, and Vibration) or Maximum
Operating 260°C Ref  ing at 25°C	Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°, ow, Shock, and Vibration)  ar Maximum  C  6  num (No Load)
erating Temperature Range  pply Voltage  2.5Vdc ±5  out Current  fmA Maxin  tput Voltage Logic High (Voh)  10% of Vd  tput Voltage Logic Low (Vol)  10% of Vd  se/Fall Time  6nSec Max  ty Cycle  50 ±5(%) (  ad Drive Capability  15pF Maxin  tput Logic Type  1 Connection  Tri-State (I)  90% of Vd  90% of Vd	°C % num (No Load)
pply Voltage  2.5Vdc ±5 6mA Maxin tput Voltage Logic High (Voh) 90% of Vd tput Voltage Logic Low (Vol) 10% of Vd se/Fall Time 6nSec Maxin ty Cycle 50 ±5(%) ( ad Drive Capability 15pF Maxin tput Logic Type CMOS 1 Connection -State Input Voltage (Vih and Vil) 90% of Vd	num (No Load)
trut Current  from Current  fr	num (No Load)
tput Voltage Logic High (Voh)  10% of Vd tput Voltage Logic Low (Vol)  10% of Vd te/Fall Time  6nSec Ma ty Cycle  50 ±5(%) ( 15pF Maxi tput Logic Type  1 Connection  Tri-State (I 90% of Vd 70% of Vd	
tput Voltage Logic Low (Vol)         10% of Vd           se/Fall Time         6nSec Max           ty Cycle         50 ±5(%) (           ad Drive Capability         15pF Maxi           tput Logic Type         CMOS           1 Connection         Tri-State (I           -State Input Voltage (Vih and Vil)         90% of Vd	d Minimum (IOH = -8mA)
ty Cycle ad Drive Capability tput Logic Type CMOS Tri-State (I -State Input Voltage (Vih and Vil)  6nSec Max 50 ±5(%) ( 50 ±5(%) ( 6nSec Max 50 ±5(%) ( 6nSe	
ty Cycle 50 ±5(%) ( ad Drive Capability 15pF Maxi tput Logic Type CMOS 1 1 Connection Tri-State (I -State Input Voltage (Vih and Vil) 90% of Vd	d Maximum (IOL = +8mA)
ad Drive Capability  tput Logic Type  CMOS  1 Connection  Tri-State (I  State Input Voltage (Vih and Vil)  90% of Vd	imum (Measured at 20% to 80% of waveform)
tput Logic Type CMOS 1 Connection Tri-State (I -State Input Voltage (Vih and Vil) 90% of Vd	Measured at 50% of waveform)
a 1 Connection Tri-State (I -State Input Voltage (Vih and Vil) 90% of Vd	num
-State Input Voltage (Vih and Vil) 90% of Vd	
	ligh Impedance)
Impedance	d Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output (High
ndby Current 10µA Max	mum (Pin 1 = Ground)
solute Clock Jitter ±100pSec	
rrt Up Time 10mSec M	Maximum
orage Temperature Range -55°C to +	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM: 1500V	
Fine Leak Test	MIL-STD-883, Method 1014, Condition A	
Flammability	UL94-V0	
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	
Mechanical Shock	MIL-STD-883, Method 2002, Condition B	
Moisture Resistance	MIL-STD-883, Method 1004	
Moisture Sensitivity	J-STD-020, MSL 1	
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010, Condition B	
Vibration	MIL-STD-883, Method 2007, Condition A	



## **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



PIN	CONNECTION
1	Tri-State
2	Case Ground
3	Output
4	Supply Voltage

LINE	MARKING
1	ECLIPTEK
2	18.432M
3	XXXXXX XXXXXX=Ecliptek Manufacturing Identifier

#### **Suggested Solder Pad Layout**

All Dimensions in Millimeters



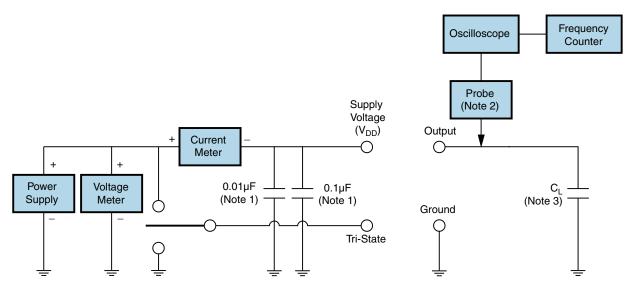
All Tolerances are ±0.1



#### **OUTPUT WAVEFORM & TIMING DIAGRAM**



#### **Test Circuit for CMOS Output**



- Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

  Note 3: Capacitance value C<sub>L</sub> includes sum of all probe and fixture capacitance.



# **Recommended Solder Reflow Methods**



## **High Temperature Infrared/Convection**

<u> </u>	
T <sub>s</sub> MAX to T <sub>∟</sub> (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>S</sub> MIN)	150°C
- Temperature Typical (T <sub>s</sub> TYP)	175°C
- Temperature Maximum (T <sub>s</sub> MAX)	200°C
- Time (t <sub>s</sub> MIN)	60 - 180 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T <sub>P</sub> Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



## **Recommended Solder Reflow Methods**



### Low Temperature Infrared/Convection 240°C

T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>S</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	60 - 120 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	240°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

## **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)